Application/Control No.	Applicant(s)/Patent under Reexamination
10/572,625	RAO ET AL.
Examiner	Art Unit

1621

Jafar Parsa

	SEARCHED				
Class	Subclass	Date	Examiner		
570	175, 176	6/10/2007	JP		

INI	INTERFERENCE SEARCHED					
Class	Subclass	Date	Examiner			
570	175, 176	6/10/2007	JP			
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SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
	DATE	EXMR		
EAST/ 2007 TO PRESENT	6/10/2007	JP		
INVENTOR NAME SEARCH	6/10/2007	JP		
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